

PICOSCALE Interferometer: Measurement of radial run-out and wobble



Abstract

The **PICOSCALE Interferometer** is a displacement sensor with picometer resolution. It may be applied in industrial applications to measure (and eventually correct) the radial run-out of a rotating workpiece or spindle.

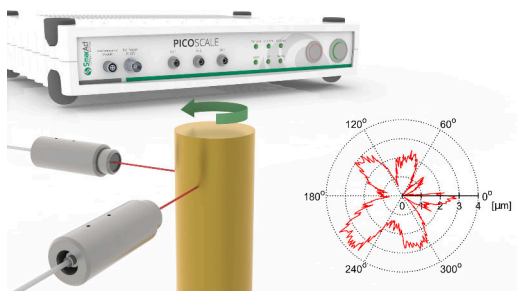


Figure 1. Schematic view of the setup. **PICOSCALE** sensor heads are used to characterize the motion of a rotating target.

1. INTRODUCTION

In high precision engineering the precise knowledge of the movement of a rotating target is of crucial interest. Radial run-out and wobble of a rotating spindle may have significant influence on the quality of a workpiece, and thus needs to be reduced. However, any correction requires an error signal, and thus the run-out and wobble need to be measured accurately. Subsequently, by applying adequate control loops or lookup-tables, the rotating target may be kept on the desired trajectory.

2. SETUP

The setup of this demonstrator is shown in Figure 2. A polished cylinder (stainless steel) was mounted on a SmarAct xy-stage as well as a rotary stage. The xy-stage can either be used to set a specific eccentricity to prove the capability of measuring large run-outs of up to 1 mm, or to correct for it. Two line focusing sensor heads (Order Code: PS-SH-L01) were assembled at a specific height with a 90° orientation to measure the eccentricity, and a third sensor head was mounted above the second one. The latter pair was used to infer the wobble of the cylinder. A **PICOSCALE** Controller with increased laser power was used for these experiments (Order Code: PS-CTRL-V1.4-HP), which is optimal for low-reflectivity or cylindrical targets.



Figure 2. Experimental setup. Three **PICOSCALE** sensor heads with line focused probe beam are targeting a polished cylinder, which is mounted on an xy- and a rotary stage. See text for details.

3. MEASUREMENT PROCEDURE

The cylinder was rotated by small increments and at each angle the relative displacement of the target with respect to each sensor head was recorded. In Figure 3 the values for the x- and y-direction are shown. The 90° phase shifted signal is (in first order) interpreted as the eccentricity of the sample.

The wobble is calculated from the position data of sensor heads 2 and 3. Consequently, a numerical fit is applied to the data that incorporates the wobble of the pin. Thus the effect that each sensor head records the shape of an ellipse instead of a circle is taken into account. The residues from the pin are due to the non-perfect surface of the pin which is overlaid with bearing errors. Figure 4 shows these residues of sensor head 1, for all recorded angles between 0 and 360°. The residues are within $\pm 1.5 \mu\text{m}$.

The line focusing heads allowed to track eccentric movements of up to 1 mm while being insensitive to wobble. Thus, the **PICOSCALE** can be used in high precision engineering or wherever radial run-out and wobble are crucial parameters.

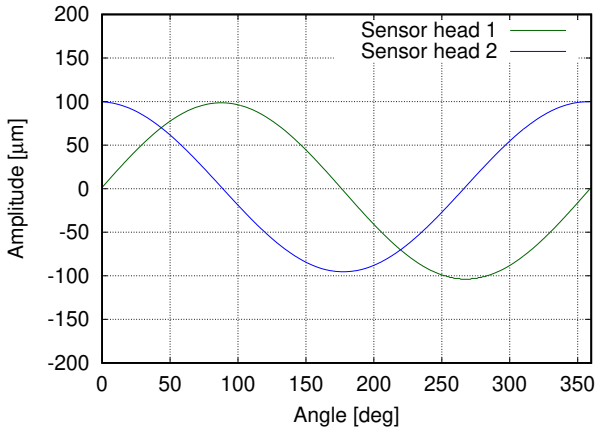


Figure 3. Measurement of the eccentric movement. The x- and y-direction is shown, that are measured by sensor head 1 and 2, respectively.

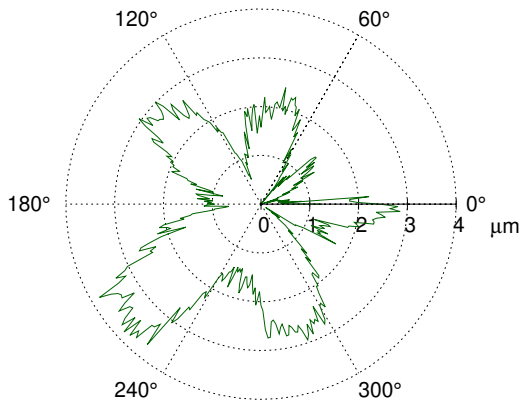


Figure 4. Residues of the data measured by sensor head 1 after the calculated eccentric movement and wobble are subtracted.

4. VARIOUS PIN DIAMETERS

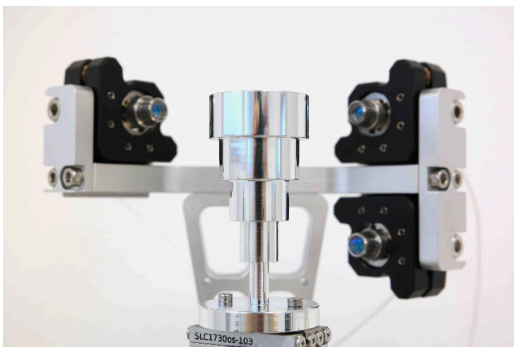


Figure 5. Probe pin with different diameters ranging from 25 mm (top) down to 5 mm (bottom).

The L01 sensor heads have been aligned to various diameters of a cylindrical surface, see Figure 5. The goal is to determine the maximum eccentric movement of the sensor head in dependence of the pin diameter. The results for the smallest pin diameter are shown in Figure 6. All measurements with larger diameters

showed similar results, and maximum eccentricities of more than 0.7 mm were always possible. The surface quality of the pin was the limiting factor, which was polished aluminum.

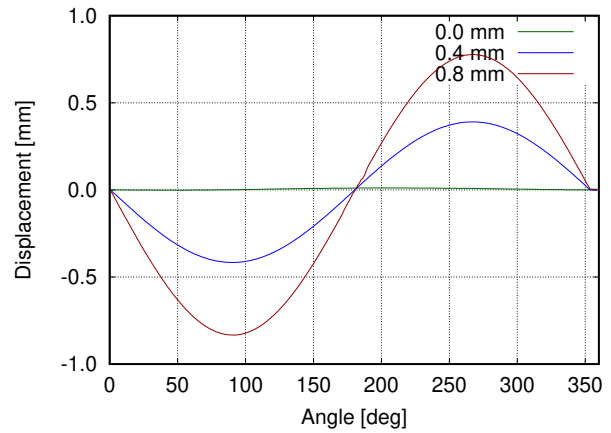


Figure 6. Displacement measurements of a rotating pin with a diameter of 5 mm and some (artificially introduced) eccentricities. Eccentricities of 0.8 mm were tracked.

Sales partner / Contacts

Germany

SmarAct GmbH

Schuetten-Lanz-Strasse 9
26135 Oldenburg
Germany

T: +49 441 - 800 879 0
Email: info-de@smaract.com
www.smaract.com

France

SmarAct GmbH

Schuetten-Lanz-Strasse 9
26135 Oldenburg
Germany

T: +49 441 - 800 879 956
Email: info-fr@smaract.com
www.smaract.com

USA

SmarAct Inc.

2140 Shattuck Ave. Suite 1103
Berkeley, CA 94704
United States of America

T: +1 415 - 766 9006
Email: info-us@smaract.com
www.smaract.com

China

Dynasense Photonics

6 Taiping Street
Xi Cheng District,
Beijing, China

T: +86 10 - 835 038 53
Email: info@dyna-sense.com
www.dyna-sense.com

Natsu Precision Tech

Room 515, Floor 5, Building 7,
No.18 East Qinghe Anning
Zhuang Road,
Haidian District
Beijing, China

T: +86 18 - 616 715 058
Email: chenye@nano-stage.com
www.nano-stage.com

Shanghai Kingway Optech Co.Ltd

Room 1212, T1 Building
Zhonggong Global Creative Center
Lane 166, Yuhong Road
Minhang District
Shanghai, China

Tel: +86 21 - 548 469 66
Email: sales@kingway-optech.com
www.kingway-optech.com

Japan

Physix Technology Inc.

Ichikawa-Business-Plaza
4-2-5 Minami-yawata,
Ichikawa-shi
272-0023 Chiba
Japan

T/F: +81 47 - 370 86 00
Email: info-jp@smaract.com
www.physix-tech.com

South Korea

SEUM Tronics

801, 1, Gasan digital 1-ro
Geumcheon-gu
Seoul, 08594,
Korea

T: +82 2 - 868 10 02
Email: info-kr@smaract.com
www.seumtronics.com

Israel

Trico Israel Ltd.

P.O.Box 6172
46150 Herzeliya
Israel

T: +972 9 - 950 60 74
Email: info-il@smaract.com
www.trico.co.il